# **Exciton localization on**  $p - i - n$  **junctions in two-dimensional crystals**

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We consider a neutral exciton localized on a model  $p - i - n$  junction defined in a two-dimensional crystal, MoSe2 and phosphorene, using a variational approach to the effective mass Hamiltonian. The variational solution to the problem with nonseparable center of mass provides the exciton density in the real space and accounts for the kinetic energy due to the exciton localization. For low values of the potential step across the junction, the exciton occupies an area which is much larger than the nominal width of the junction. Localization of the exciton within the junction area is accompanied by the appearance of the dipole moment induced by the local electric field. The induced dipole moment becomes a linear function of the potential step only when the step is sufficiently large. In consequence, the energy dependence on the step value is nonparabolic. We demonstrate that the exciton gets localized not exactly at the center of the junction but on the side which is more energetically favorable for the heavier carrier: electron or hole.

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## **I. INTRODUCTION**

Reduction of dimensionality and large carrier effective masses in monolayer transition-metal dichalcogenides [\[1,2\]](#page-6-0) and phosphorene [\[3,4\]](#page-6-0) result in large exciton binding energies [\[5–12\]](#page-6-0) exceeding by two orders of magnitude the corresponding values in bulk semiconductors. Large binding energy allows for tuning the exciton line in the luminescent spectrum by the Stark effect induced by an in-plane electric field [\[9\]](#page-6-0) which leads to a redshift of the electron-hole recombination energy due to the interaction of the intrinsic or induced exciton dipole moment with the field. The Stark effect was studied for states in quantum wells [\[13,14\]](#page-6-0) or quantum dots [\[15–18\]](#page-6-0) where the quantum confinement stabilized the weakly bound exciton against dissociation by the electric field. Conversely, the Stark effect for strongly bound excitons in a transition-metal dichalcogenide has recently been used to trap the excitons on the electric field at the  $p - i - n$  junction [\[19\]](#page-6-0).

The purpose of the present work is to describe the exciton confinement in a model of the  $p - i - n$  junction by a numerical albeit exact solution of the two-particle problem. The trapping mechanism was explained  $[19]$  as due to an effective potential for the exciton that contains a term due to the electric field  $V_{\text{eff}}(x) = -\frac{1}{2}\alpha_p |F_x(x)|^2$ , where  $F_x$  is the electric field at the junction and  $\alpha_p$  is the polarizability of the exciton, which for the homogeneous electric field can be determined by the solution of the electron-hole problem in the relative electron-hole coordinates [\[9,10,19\]](#page-6-0). The electric field in the junction  $[19]$  is not homogeneous and the motion of the center of mass of the exciton does not separate from the eigenproblem in the relative coordinates. Therefore, the center of mass requires treatment on equal rights with the relative electron-hole coordinates which we provide in this work. The solution accounts for the kinetic energy due to the exciton confinement at the junction and provides information

on the exciton localization: its mean position and the extent of its wave function in the real space. We find that the range of exciton confinement depends strongly on the value of the potential step at the junction, and for a low value of the step the confinement range can largely exceed the nominal width of the junction. Then, the wave function is present in a region with a widely changing electric field that makes the homogeneous field solution not directly adequate to a local field case. In particular, the electric field at the center of the junction is a linear function of the potential step at the junction, but the induced dipole moment is not and the reaction of the exciton energy on the step is not parabolic as for Stark effect in the homogenous electric field.

### **II. THEORY**

We work with the effective band Hamiltonian for the electron-hole pair at the junction

$$
H = -\frac{\hbar^2}{2m_e^x} \frac{\partial^2}{\partial x_e^2} - \frac{\hbar^2}{2m_e^y} \frac{\partial^2}{\partial y_e^2} - \frac{\hbar^2}{2m_h^x} \frac{\partial^2}{\partial x_h^2} - \frac{\hbar^2}{2m_h^y} \frac{\partial^2}{\partial y_h^2} + V(x_e) - V(x_h) - V_{eh}(r_{eh}),
$$
 (1)

with  $m_{e/h}^{y/x}$  standing for the electron or hole mass along the *x* or *y* direction. We use the model potential of the  $p - i - n$  junction in the form  $V(x) = -\frac{2V_0}{\pi} \arctan(\frac{x}{d})$  where  $V_0$  defines the scale of the potential step along the junction and the variation rate is given by *d*. The model potential is plotted in Fig. [1](#page-1-0) for the electron  $[V(x)]$ ; red line] and the hole  $[-V(x)]$ ; black line]. The potential pushes the noninteracting carriers away from the junction center. In Eq.  $(1)$   $V_{eh}(r_{eh})$  is the effective 2D interaction given by the Keldysh potential [\[7–12,19–22\]](#page-6-0),

$$
V_{eh}(r) = \frac{e^2}{4\pi\epsilon_0} \frac{\pi}{2\epsilon r_0} [H_0(r/r_0) - Y_0(r/r_0)],\tag{2}
$$

<span id="page-1-0"></span>

FIG. 1. (a) The model potential of the  $p - i - n$  junction  $V(x) =$  $-\frac{2eV_0}{\pi}$  arctan( $\frac{x}{d}$ ) for the electron (red curve) and  $-V(x)$  potential for the hole (black curve) for  $d = 15$  nm and  $V_0 = 100$  meV. (b) The exciton density as a function of the center-of-mass position for  $d = 15$ nm and three values of  $V_0$  for the lowest-energy bound exciton state. (c) The probability density as a function of the electron-hole distance in the *x* direction  $x_{eh}$  for  $V_0 = 0$  (black line) and  $V_0 = 200$  meV (red line). MoSe<sub>2</sub> parameters are applied.

where  $H_0$  and  $Y_0$  are the Struve and Bessel functions of the second kind,  $r_0$  is the screening length that is a measure of the polarizability of the 2D semiconductor, and  $\epsilon$  is the dielectric constant. At large electron-hole distances  $r \gg r_0$ the interaction potential tends to the 3D Coulomb form 1/*r*. At small electron-hole distances  $r \ll r_0$ ,  $V_{eh}$  acquires a logarithmic singularity of the 2D Coulomb potential. For evaluation of the interaction potential we use the method of Ref. [\[22\]](#page-6-0). The intrinsic area where the exciton confinement occurs in the experiment [\[19\]](#page-6-0) has a length of several dozens of nanometers. Here we discuss the results with the parameter *d* ranging from 15 nm to 60 nm. The variation of the potential by  $V_0$  and  $1.5V_0$ occurs at lengths of 2*d* and 2.4*d*, respectively. In the experimental situation [\[19\]](#page-6-0) the carriers are additionally confined by the space-charge density outside the intrinsic region. Here we assume that the depletion region is arbitrarily wide for a

description of the exciton binding purely on the local electric field.

Using the center-of-mass coordinates  $X = \frac{m_e^x x_e + m_h^x x_h}{M_x}$ ,  $Y =$  $\frac{m_e^y y_e + m_h^y y_h}{M_y}$ , with  $M_x = m_e^x + m_h^x$ ,  $M_y = m_e^y + m_h^y$  and the relative electron-hole coordinates  $x_{eh} = x_e - x_h$  and  $y_{eh} = y_e$  – *yh*, the Hamiltonian is written as

$$
H = -\frac{\hbar^2}{2M_x} \frac{\partial^2}{\partial X^2} - \frac{\hbar^2}{2M_y} \frac{\partial^2}{\partial Y^2} - \frac{\hbar^2}{2\mu_x} \frac{\partial^2}{\partial x_{eh}^2} - \frac{\hbar^2}{2\mu_y} \frac{\partial^2}{\partial y_{eh}^2} + V(x_e) - V(x_h) - V_{eh}(r_{eh}),
$$
\n(3)

with the reduced masses  $\mu_x = m_e^x m_h^x / M_x$  and  $\mu_y = m_e^y m_h^y / M_y$ . The motion of the center of mass along the junction separates from the rest of the coordinates, and we assume that the wave function over *Y* has the form of a plane wave with a zero wave vector. For a constant electric field oriented along the *x* direction, studied for the discussion of the Stark effect [\[9,10,19\]](#page-6-0), the center-of-mass coordinate *X* also separates, but this is not the case for the present problem with the nonlinear potential of the junction *V* .

The exciton states are determined using a variational approach [\[8\]](#page-6-0) with Gaussian basis

$$
\Phi(x_{eh}, y_{eh}, X)
$$
\n
$$
= \sum_{ijk} c_{ijk} \phi_{ijk}(x_{eh}, y_{eh}, X)
$$
\n
$$
= \sum_{ijk} c_{ijk} \exp\left(-\frac{(x_{eh} - \kappa_i)^2}{\alpha} - \frac{(y_{eh} - \gamma_j)^2}{\beta} - \frac{(X - \eta_k)^2}{\gamma}\right),
$$
\n(4)

where *cijk* are the linear variational coordinates determined by solving the generalized eigenvalue problem  $\textbf{Hc} = E \textbf{Sc}$ , with the matrix elements  $H_{i'j'k',ijk} = \langle \phi_{i'j'k'} | H | \phi_{ijk} \rangle$  and  $S_{i'j'k',ijk} =$  $\langle \phi_{i'j'k'} | \phi_{ijk} \rangle$ . The centers of the Gaussian are distributed on a 3D mesh with  $\kappa_i = i \Delta_{x_{eh}}, \gamma_j = j \Delta_{y_{eh}},$  and  $\eta_k = k \Delta_X$ , with *i*, *j*, and *k* being integers ranging from −*N* to *N*. The total number of Gaussians used in the basis is  $(2N + 1)^3$ . The values of  $\Delta$  select the region in space to be described by the variational wave function. The spacings  $\Delta$  and the localization parameters of the Gaussian  $\alpha$ ,  $\beta$ , and  $\gamma$  are determined as nonlinear variational parameters by minimization of the energy estimate. Separate parameters for *xeh* and *yeh* are needed for phosphorene with its strongly anisotropic effective masses [\[23,24\]](#page-6-0) but also for the case of isotropic effective masses applied for  $MoSe<sub>2</sub>$  due to the external potential acting only in the *x* direction. Convergence of the results for the pa-rameters of MoSe<sub>2</sub> is given in Table [I](#page-2-0) for  $V_0 = 0$  and Table [II](#page-2-0) for  $V_0 = 300$  meV and  $d = 15$  nm. As the energy convergence is reached with increasing *N* the average electron-hole distance  $\sqrt{r_{eh}^2}$  (Table [I,](#page-2-0) Table [II\)](#page-2-0) and the relative electron-hole displacement along the local electric field  $\langle x_{eh} \rangle$  grow (Table [II\)](#page-2-0) but the range of the exciton localization  $\Delta X$  decreases (Table [II\)](#page-2-0). Reference [\[19\]](#page-6-0) with the MoSe<sub>2</sub> parameters applied in Tables [I](#page-2-0) and [II](#page-2-0) indicates  $-217$  meV as the ground-state energy of the free exciton  $(V_0 = 0)$ ; Table [I\)](#page-2-0). For the rest of the paper we adopt  $N = 8$ , i.e., 17 Gaussians describing the wave function in each coordinate, i.e., for the total number of  $17<sup>3</sup> = 4913$  Gaussian functions used in the basis. The basis

<span id="page-2-0"></span>TABLE I. Convergence of the Gaussian basis for a free exciton  $(V_0 = 0)$  for MoSe<sub>2</sub> parameters. The first column lists the parameter *N* defining the number of basis elements. The second column gives the ground-state energy estimate and the third column the average electron-hole distance calculated as the square root of the mean value of the squared electron-hole distance.

N	$E$ (meV)	(nm)
	$-213.035$	1.0932
2	$-216.038$	1.1310
3	$-216.502$	1.1546
$\overline{4}$	$-216.784$	1.1525
.5	$-216.902$	1.1567
6	$-216.953$	1.1588
7	$-216.974$	1.1600
8	$-216.981$	1.1607
9	$-216.983$	1.1611

(4) is flexible enough to account for both the bound excitons and dissociated electron-hole pairs (see below).

#### **III. RESULTS AND DISCUSSION**

## **A. MoSe**<sub>2</sub>

We first consider the material where the exciton trapping at the junction was accomplished  $[19]$ , MoSe<sub>2</sub>, the transitionmetal dichalcogenide for which an isotropic effective mass model can be adopted with  $m_e^x = m_e^y = 0.7m_0$  [\[19,25\]](#page-6-0) and  $m_h^x = m_h^y = 0.6m_0$  [\[19,26\]](#page-6-0). We take the dielectric constant  $\epsilon = 4.4$  and the screening length  $r_0 = 0.886$  nm after Ref. [\[19\]](#page-6-0).

Figure  $1(b)$  shows the lowest bound exciton state density calculated as  $\rho_X(X) = \int_{-\infty}^{\infty} d_{x_{eh}} \int_{-\infty}^{\infty} d_{y_{eh}} |\Phi(x_{eh}, y_{eh}, X)|^2$  for  $d = 15$  nm. The exciton is localized near the area where the potential gradient is maximal, and the exciton localization increases with  $V_0$ . The center of the exciton is localized

TABLE II. Convergence of the Gaussian basis for a junction with  $V_0 = 300$  meV and  $d = 15$  nm. The first column gives the parameter *N* that defines the size of the Gaussian basis. The second column contains the energy estimate of the lowest state bound at the junction. The third column lists the average electron-hole distance. The fourth column provides the range of exciton localization at the junction calculated as  $\Delta X = \langle (X - \langle X \rangle)^2 \rangle^{1/2}$  and the last one is the relative displacement of the electron and hole due to the electric field at the junction. For  $V_0 = 0$ , as in Table I,  $\Delta X$  is infinite and  $\langle x_{eh} \rangle = 0$ .

N	$E$ (meV)	$\langle r_{eh}^2 \rangle$ (nm)	$\Delta X$ (nm)	$\langle x_{eh} \rangle$ (nm)
1	$-213.277$	1.0972	9.5629	0.06053
2	$-216.038$	1.1392	9.1612	0.07356
3	$-216.838$	1.1546	9.0222	0.07984
$\overline{4}$	$-217.135$	1.1627	8.8809	0.08315
5	$-217.262$	1.1674	8.8063	0.08509
6	$-217.319$	1.1704	8.7565	0.08637
7	$-217.344$	1.1721	8.7270	0.08714
8	$-217.353$	1.1731	8.7089	0.08768
9	$-217.357$	1.1737	8.6980	0.08794



FIG. 2. Cross section of the lowest-energy bound wave function taken at  $y_{eh} = 0$ ,  $\Phi(x_{eh}, y_{eh} = 0, X)$  for  $d = 15$  nm and MoSe<sub>2</sub> parameters.

off the center of the junction on the side of the junction where the heavier carrier—here the electron—has a lower potential energy (see below). Figure  $1(c)$  shows the density over the horizontal electron-hole distance  $\rho_{x_{eh}}(x_{eh}) =$ <br> $\int_{-\infty}^{\infty} dx \int_{-\infty}^{\infty} d_{y_{eh}} |\Phi(x_{eh}, y_{eh}, X)|^2$ . The potential of the consid- $-\infty$  *d<sub>X</sub>*  $\int_{-\infty}^{\infty} d_{y_{eh}} |\Phi(x_{eh}, y_{eh}, X)|^2$ . The potential of the considered range produces only a small shift of the density to a more positive *xeh*, with the electron shifted to a more positive *x* and the hole to a more negative *x* position. The electron and hole densities calculated from the total wave function (not shown) are nearly identical to the exciton density  $\rho_X$  due to the large extent of  $\rho_X$  and the relative strong localization of the pair.

Figure 2 displays the cross section of the lowest-energy bound electron-hole wave function taken at  $y_{eh} = 0$  for  $V_0 =$ 50 meV, 100 meV, and 200 meV. The range of the localization changes radically with  $V_0$  only in the  $X$  coordinate and not in *xeh*.

The process of exciton localization at the junction is illustrated in Fig. [3](#page-3-0) where we considered several junction width parameters *d*. The energy decrease with  $V_0$  in Fig.  $3(a)$  is a signature of the carrier separation by the electric field which, as we find, does not start at zero  $V_0$  [Fig. [3\(a\)\]](#page-3-0). The exciton localization in the region of a large electric field is associated with the cost of additional kinetic energy. For larger values of

<span id="page-3-0"></span>

FIG. 3. (a) Energy of the lowest bound exciton state as a function of  $V_0$  for varied values of the width of the junction  $d$  for MoSe<sub>2</sub>. The dashed line shows the results for the junction potential replaced by its linear approximation  $V_l(x) = -\frac{2V_0}{\pi} \frac{x}{d}$  for  $d = 30$  nm. (b) The average shift of the electron and hole position along the direction of the junction *xeh*. The dashed line corresponds to the linear approximation as in (a). (c) The exciton localization width calculated from the wave function as  $\Delta X = \langle (X - \langle X \rangle)^2 \rangle^{1/2}$ . (d) The average position of the exciton center of mass. The line is plotted for  $V_0$  where  $\Delta X$ falls below 500 nm. The results correspond to the lowest-energy bound exciton state. (e) The square root of the average square of the electron-hole distance for the lowest-energy state localized at the junction (blue line) and the corresponding values for *xeh* (black line) and  $y_{eh}$  (red line) coordinates for  $d = 15$  nm.

*d* the electric field at the junction is lower, but the extent of exciton localization at the junction is decreased. The energy shift in the homogenous electric field falls with the square of the field  $[9,10]$  which for the present potential implies  $a -1/d^2$  dependence while the exciton confinement energy depends on the localization as  $1/d^2$ . The two effects seem to cancel each other out in the constant energy range of small *V*<sub>0</sub>. We observe that a nonzero value of the potential step is necessary to induce a significant dipole moment [Fig. 3(b)]. As nonzero  $V_0$  is introduced the range of exciton localization [Fig.  $3(c)$ ] becomes finite. However, for low  $V_0$  most of the exciton stays outside of the action range of the local electric field (potential gradient) at the junction. For all studied *d* values, the exciton size in terms of  $\Delta X = \langle (X - \langle X \rangle)^2 \rangle^{1/2}$ becomes equal to double the width parameter  $\Delta X = 2d$  for  $V_0 \simeq 100$  meV. Only once the exciton is localized at the junction does the electron-hole system energy start to decrease visibly.

For comparison in Figs.  $3(a)$  and  $3(b)$  we plot with the dashed red line the results for the homogenous electric field, i.e., for the potential of the junction replaced by its linear approximation:  $V_l(x) = -\frac{2V_0}{\pi} \frac{x}{d}$ , for  $d = 30$  nm. For  $V_l(x)$  potential the dipole moment grows linearly with  $V_0$  [Fig.  $3(b)$ ] starting from  $V_0 = 0$ . The linear dependence of the dipole moment via its interaction with the field produces the parabolic  $E(V_0)$  dependence [the dashed line in Fig. 3(a)]. For the junction potential  $V(x)$ , the growth of the dipole moment with  $V_0$ follows after a delay. For all *d* considered the dipole moment starts to grow for  $V_0 \gtrsim 20 \text{ meV}$  and becomes a linear function of  $V_0$  only above  $\simeq 100$  meV.

The results for the homogeneous electric field given by the dashed line in Fig.  $3(a)$  are obtained for the Hamiltonian that is equivalent to Eq. (10) of the Methods section of Ref. [\[19\]](#page-6-0). The Stark energy shift that we obtain with our variational wave function for the constant electric field of  $10 \text{ V}/\mu \text{m}$ ,  $20 \text{ V}/\mu \text{m}$ , and 30 V/ $\mu$ m is equal to -0.415 meV, -1.708 meV, and −4.076 meV. These shifts are in very good agreement with Fig. 10(a) of the Extended Data of Ref. [\[19\]](#page-6-0).

Figure  $3(d)$  shows that the center of mass of the exciton approaches the center of the junction only in the  $V_0 \rightarrow \infty$ limit, and for finite  $V_0$  it stays on the positive side of the center of the junction. We return to this point for phosphorene, where the effect is more pronounced.

The experiment of Ref. [\[19\]](#page-6-0) studied the diamagnetic shift of the exciton energy that is related to the average square of the electron-hole distance. In Fig.  $3(e)$  we plot the square root of this quantity by the blue line for the junction width of  $d = 15$  nm. The black and red lines indicate the components due to the *xeh* and *yeh* components, respectively. The two last values are multiplied by  $\sqrt{2}$  for presentation. The local electric field produces the electron-hole displacement [Fig. 3(b)] that is consistent with the dependence of  $\langle x_{eh}^2 \rangle$  of Fig. 3(e). The separation of the carriers in the *xeh* direction reduces the mutual attractive potential that implies an increased distance also in the *yeh* direction. Nevertheless, the dependence of the quantities of Fig.  $3(e)$  on  $V_0$  is weak and they remain very small barely exceeding 1 nm. Reference [\[19\]](#page-6-0) stated that the diamagnetic shift of the 1*s* exciton state is too small to be resolved experimentally and indicated 1 nm as the approximate exciton Bohr radius.

<span id="page-4-0"></span>

FIG. 4. The lowest energy estimate for  $d = 15$  nm with  $V_0 =$ 100 meV (red line) and 300 meV (black line) for fixed  $\Delta_X$  = 18 nm [see the description of the variational wave function given by Eq. [\(4\)](#page-1-0)], as a function of  $\Delta_{x_{eh}}$ . For this plot we keep  $\Delta_{y_{eh}} = \Delta_{x_{eh}}$ and the Gaussian localization parameters  $\alpha = \frac{\Delta_X^2}{1.5}$  and  $\beta = \gamma = \frac{\Delta_{\chi_{eh}}^2}{1.5}$ . The minimum near  $\Delta_{\text{xeh}} = 0.8$  nm corresponds to the bound exciton. The results for large  $\Delta_{\text{xeh}}$  limit tend to  $-2V_0$  and correspond to the dissociated exciton.

The dissociated electron-hole pair for the present model potential has minimal energy equal to  $-2V_0$ . Therefore, the dissociated electron-hole pair appears in the ground state for  $V_0$  roughly exceeding  $E_{gs}(0)/2$ . In fact, the value of  $V_0$  that allows for the dissociation is somewhat larger than  $E_{gs}(V_0 =$  $0$ /2 since the exciton energy decreases with  $V_0$ . The critical value of the potential that allows for the dissociation is defined as  $E_{gs}(V_0) = -2V_0$ . For  $d = 60$  nm, 30 nm, 15 nm, and 5 nm we find the following values of the critical potential  $V_0 = 108.491$  meV, 108.494 meV, 108.504 meV, and 108.58 meV. The dependence of the critical potential values on *d* becomes significant only for very low junction width *d*. In the experimental conditions the *d* value cannot be made much smaller than 5 nm; hence  $E_{gs}(0)/2$  is a good estimate for the critical potential value that allows for the formation of the dissociated ground state.

For  $V_0$  above  $E_{gs}(0)/2$  the bound hole pair is not the ground state of the system, similarly to the studies of the Stark effect for a nonzero homogeneous electric field  $[9,10,19]$ . The applied basis resolves two separate minima for the bound and dissociated exciton. The results of the Hamiltonian diagonalization as a function of  $\Delta_{x_{eh}} = \Delta_{y_{eh}}$  are given in Fig. 4, with the lower energy state corresponding to the bound exciton or the dissociated pair for  $V_0 = 100$  meV and 300 meV, respectively. Here, we discuss only the properties of the bound electron-hole state for both  $V_0$  below or above the dissociation threshold. The gradient minimalization method applied for optimization of the nonlinear variational parameters tends to the closest energy minimum, so one can choose between the dissociated or bound exciton states.

## **B. Phosphorene**

The effective masses in phosphorene exhibit strong anisotropy with larger (smaller) values in the zigzag (armchair) crystal direction [\[23,24\]](#page-6-0). For monolayer black phosphorous, we adopt the values of effective masses derived by fitting the results of the single-band approximation to the results of the atomistic tight-binding [\[27\]](#page-7-0) modeling for



FIG. 5. (a) Energy of the lowest bound exciton state as a function of  $V_0$  for monolayer phosphorene with the direction defining the  $p - i - n$  junction *x* aligned to the zigzag ("z"; black line) or armchair ("a"; red line) crystal direction. (b) The average shift of the electron and hole position along the direction of the junction *xeh*. (c) The exciton localization width *X*. (d) The average position of the exciton center of mass.

the harmonic oscillator confinement potential of Ref. [\[28\]](#page-7-0). That is, we take  $m_a^e = 0.17037m_0$ ,  $m_z^e = 0.85327m_0$  for the electron masses in the armchair and zigzag directions [\[28\]](#page-7-0), respectively. For the hole we take  $m_a^h = 0.18972m_0$  for the armchair direction [\[28\]](#page-7-0). The hole mass in the zigzag direction was not adopted from Ref.  $[28]$  but set to  $2.8m_0$ . The literature values for the zigzag mass of the hole vary from  $\approx 1.13m_0$  [\[24](#page-6-0)[,29\]](#page-7-0) to  $\approx 5$  [\[30\]](#page-7-0) or  $\approx 6$  [\[31\]](#page-7-0). The selected choice of the effective masses provides the electron-hole pair reduced masses that agree with the ones given in Table II of Ref. [\[4\]](#page-6-0) for monolayer phosphorene. For the interaction potential we take the screening length of  $r_0 = 1.079$  nm and the effective

<span id="page-5-0"></span>

FIG. 6. Cross section of the wave function taken at  $y_{eh} = 0$ ,  $\Phi(x_{eh}, y_{eh} = 0, X)$  for  $d = 15$  nm and phosphorene parameters. In (a) and (b) the  $p - i - n$  junction is defined along the zigzag crystal direction. Armchair direction is chosen in (c) and (d).

dielectric constant of  $\epsilon = 2.4$  after the Supporting Information to Ref. [\[4\]](#page-6-0).

In calculations for phosphorene we fix the junction width parameter to  $d = 15$  nm. We keep the junction potential variation along the *x* axis that we align with either armchair or zigzag crystal direction. The reaction of the exciton energy to the external potential is prompter for the junction defined along the armchair direction [Fig.  $5(a)$ ], and the induced dipole moment  $[Fig. 5(b)]$  $[Fig. 5(b)]$  is also larger in this direction where the masses are lighter. This finding is consistent with the conclusions of Ref. [\[9\]](#page-6-0) for the case of a homogeneous electric field in phosphorene.



FIG. 7. Potential landscape  $V(x_e) - V(x_h)$  at the junction for  $d = 15$  nm,  $V = 100$  meV for phosphorene parameters and the junction defined along the armchair (a) and zigzag (b) crystal direction.

The cross sections of the wave function for  $y_{eh} = 0$  are plotted in Fig. 6 for the zigzag  $[(a), (b)]$  and armchair  $[(c),$ (d)] orientation of the wave function. The orientation of the junction has a pronounced effect on the exciton localization along the *X* axis with the total mass  $M_x = 0.36m_0$  for the armchair orientation and  $M_X = 3.65m_0$  for the junction defined along the zigzag crystal direction. The reduced mass in the  $x_{eh}$  direction is 0.089 $m_0$  for the armchair and 0.65 $m_0$ for the zigzag orientation, hence the varied localization along the vertical axis of Fig. 6. Figure  $5(c)$  indicates that the width of the exciton wave function becomes equal to 2*d* for  $V_0 \simeq$ 100 meV ( $V_0 \simeq 210$  meV) for the junction defined along the zigzag (armchair) direction.

For phosphorene, the center of the exciton density is shifted to the left of the junction center [Fig.  $6$  and Fig.  $5(d)$ ]. The shift is smaller for the armchair orientation of the junction [Figs.  $6(c)$ ,  $6(d)$ ] and large for the zigzag-oriented junction [Figs.  $6(a)$ ,  $6(b)$  and Fig.  $5(d)$ ]. As a general rule, the shift is large when one of the carriers is much heavier than the other and the shift appears in the direction of lower potential energy in the  $V(x)$  potential for the heavier carrier. In the results for  $MoSe<sub>2</sub>$  (precedent subsection), the shift was observed to the positive side of the junction and the electron was slightly heavier. For phosphorene, the hole is heavier and the center of mass is shifted to the negative side of the junction. For the zigzag orientation, the mass difference is very pronounced—hence, the strong shift, much larger than the average electron-hole distance. The shift is directly related to the potential landscape at the junction. In Fig. 7 we plot the external potential for both carriers, i.e.,  $V(x_e) - V(x_h)$  on the  $(X, x_{eh})$  plane. The anisotropy of the masses translates to a shift of the potential minimum to the negative side of *X*, which <span id="page-6-0"></span>produces the pronounced asymmetry for the zigzag orientation of the junction. The interaction potential of Hamiltonian (3) is independent of *X* and creates a valley along  $x_{eh} = 0$ of depth that depends on *yeh*. The displacement of the wave function to positive  $x_{eh}$  is not very pronounced [see Fig. [6](#page-5-0)] and Fig. [5\(b\)\]](#page-4-0) since the strong interaction potential keeps the carriers close to one another. Instead, the wave function is shifted to the negative side of the junction where the minimum of the potential landscape is closer to the  $x_{eh} = 0$  axis. The effect is particularly well seen in Figs.  $6(a)$  and  $6(b)$  [see also Fig.  $5(d)$ ]. Note that for a homogeneous electric field, only the reduced masses and not the separate masses of the electron and hole matter for the properties of the bound exciton states [9].

## **IV. SUMMARY AND CONCLUSIONS**

We have studied bound electron-hole pairs at a  $p - i - n$ junction defined within a two-dimensional crystal using a model with a finite spatial range and potential step  $V_0$  across the junction with the electric field in the center of the junction proportional to *V*0. The problem was solved with a variational calculation using the basis of Gaussians centered on a grid spanned by the relative coordinates of the carriers and the center of mass, which is not separable in the inhomogeneous

electric field. The appearance of the dipole moment induced by the local electric field at the junction is accompanied by a buildup of the exciton kinetic energy as a result of the localization at the junction. The compensation of the two contributions leads to a range of values of the potential step of the junction  $V_0$  that has a negligible influence on the exciton energy. For  $MoSe<sub>2</sub>$  and phosphorene, localization of the exciton wave function in a range comparable with the junction length requires a potential difference across the junction of the order of  $V_0 \simeq 100$  meV. For lower  $V_0$  values, the carriers occupy the region in space where the electric field is much smaller than at the center of the junction. The induced dipole moment dependence on the potential step  $V_0$  deviates from linear, which is expected for the Stark effect in a homogenous electric field. In consequence, the exciton energy is not a parabolic function of *V*0. We have demonstrated that the localized exciton is shifted off the center of the junction in the direction in which the junction potential energy for the heavier carrier is lower.

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